SO-8

Top View



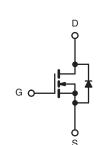
SI4090DY-T1-GE3-VB Datasheet

N-Channel 100-V (D-S) Super Trench Power MOSFET

PRODUCT SUMMARY						
V _{DS} (V)	R _{DS(on)} (Ω) Max.	I _D (A) ^a	Q _g (Typ.)			
	0.0082 at V _{GS} = 10 V	15.5				
100	0.0095 at V _{GS} = 7.5 V	14.8	27.9 nC			
	0.0105 at V _{GS} = 6.0 V	14.0				

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N-Channel MOSFET

FEATURES

- Super Trench technology Power MOSFET
- Excellent gate charge x Rds (on) product(FOM)
- Very low on-resfistance Rds (on)
- 100 % R_g and UIS Tested



COMPLIANT HALOGEN FREE

APPLICATIONS

- DC/DC Primary Side Switch
- Telecom/Server
- Motor Drive Control
- Synchronous Rectification

Parameter	Symbol	Limit	Unit		
			Oint		
Drain-Source Voltage		V _{DS}	100	V	
Gate-Source Voltage		V_{GS}	± 20		
	T _C = 25 °C		15.5		
Continuous Drain Current /T 150 °C)	T _C = 70 °C		13		
Continuous Drain Current (T _J = 150 °C)	T _A = 25 °C	I _D	10.2 ^{b, c}		
	T _A = 70 °C		7.4 ^{b, c}	Α Α	
Pulsed Drain Current (t = 300 μs)		I _{DM}	70	^	
0 " 0 5 5 1 0	T _C = 25 °C		7		
Continuous Source-Drain Diode Current	T _A = 25 °C	- I _S	3.1 ^{b, c}		
Single Pulse Avalanche Current	L = 0.1 mH	I _{AS}	30		
Avalanche Energy	L=0.1 IIII	E _{AS}	45	mJ	
	T _C = 25 °C		7.8		
Maximum Dawar Dissinction	T _C = 70 °C		5	١٨/	
Maximum Power Dissipation	T _A = 25 °C	P _D	3.5 ^{b, c}	W	
	T _A = 70 °C		2.2 ^{b, c}		
Operating Junction and Storage Temperature Range		T _J , T _{stq}	- 55 to 150	°C	

THERMAL RESISTANCE RATINGS							
Parameter	Symbol	Typical	Maximum	Unit			
Maximum Junction-to-Ambient ^{b, d}	t ≤ 10 s	R _{thJA}	29	35	°C/W		
Maximum Junction-to-Foot (Drain)	Steady State	R_{thJF}	13	16	0/11		

Notes:

- a. Based on T_C = 25 °C.
- b. Surface mounted on 1" x 1" FR4 board.
- c. t = 10 s.
- d. Maximum under steady state conditions is 80 °C/W.



Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit
Static				•		
Drain-Source Breakdown Voltage	V_{DS}	$V_{GS} = 0 \text{ V, I}_{D} = 250 \mu\text{A}$	100			V
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	J 050A		67		1404
V _{GS(th)} Temperature Coefficient	$\Delta V_{GS(th)}/T_{J}$	- I _D = 250 μA		- 6.4		mV/°C
Gate-Source Threshold Voltage	V _{GS(th)}	$V_{DS} = V_{GS}$, $I_D = 250 \mu A$	2		3.3	٧
Gate-Source Leakage	I _{GSS}	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 20 \text{ V}$			± 100	nA
Zava Cata Valtana Duain Courant	I _{DSS}	V _{DS} = 100 V, V _{GS} = 0 V			1	μΑ
Zero Gate Voltage Drain Current		V _{DS} = 100 V, V _{GS} = 0 V, T _J = 55 °C			10	
On-State Drain Current ^a	I _{D(on)}	$V_{DS} \ge 5 \text{ V}, V_{GS} = 10 \text{ V}$	30			Α
		V _{GS} = 10 V, I _D = 15 A		0.0082		
Drain-Source On-State Resistance ^a	R _{DS(on)}	$V_{GS} = 7.5 \text{ V}, I_D = 12 \text{ A}$		0.0095		Ω
		$V_{GS} = 6.0 \text{ V}, I_D = 10 \text{ A}$	0.0105			
Forward Transconductance ^a	9 _{fs}	V _{DS} = 15 V, I _D = 15 A		54		S
Dynamic ^b				<u> </u>		
Input Capacitance	C _{iss}			3410		pF
Output Capacitance	C _{oss}	V _{DS} = 50 V, V _{GS} = 0 V, f = 1 MHz		790		
Reverse Transfer Capacitance	C _{rss}			160		
Tabal Oata Obarra		$V_{DS} = 50 \text{ V}, V_{GS} = 10 \text{ V}, I_{D} = 10 \text{ A}$		45.6	69	nC
Total Gate Charge	Q_{g}	Q _g		27.9	42	
Gate-Source Charge	Q_{gs}	$V_{DS} = 50 \text{ V}, V_{GS} = 6 \text{ V}, I_{D} = 10 \text{ A}$		8.5		
Gate-Drain Charge	Q_{gd}]		9.2		
Output Charge	Q _{oss}	V _{DS} = 50 V, V _{GS} = 0 V		63	95	
Gate Resistance	R_g	f = 1 MHz	0.4	1.3	2.6	Ω
Turn-On Delay Time	t _{d(on)}			16	32	
Rise Time	t _r	$V_{DD} = 50 \text{ V}, R_L = 5 \Omega$		11	22	
Turn-Off Delay Time	t _{d(off)}	$I_D \cong 10 \text{ A}, V_{GEN} = 7.5 \text{ V}, R_g = 1 \Omega$		35	70	
Fall Time	t _f			10	20	no
Turn-On Delay Time	t _{d(on)}			14	28	ns
Rise Time	t _r	$V_{DD} = 50 \text{ V}, R_L = 5 \Omega$		10	20	
Turn-Off Delay Time	t _{d(off)}	$I_D \cong 10 \text{ A}, V_{GEN} = 10 \text{ V}, R_g = 1 \Omega$		36	70	
Fall Time	t _f			10	20	
Drain-Source Body Diode Characteristi	cs					
Continuous Source-Drain Diode Current	I _S	T _C = 25 °C			7	Λ.
Pulse Diode Forward Current ^a	I _{SM}				70	A
Body Diode Voltage	V_{SD}	I _S = 5 A		0.75	1.1	V
Body Diode Reverse Recovery Time	t _{rr}			49	95	ns
Body Diode Reverse Recovery Charge	Q _{rr}	1 - 10 A di/dt - 100 A/vo T - 05 °C		58	115	nC
Reverse Recovery Fall Time	t _a	$I_F = 10 \text{ A, di/dt} = 100 \text{ A/}\mu\text{s, T}_J = 25 \text{ °C}$		21		
Reverse Recovery Rise Time		t _b		28		ns

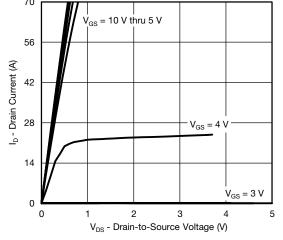
Notes:

- a. Pulse test; pulse width \leq 300 $\mu s,$ duty cycle \leq 2 % b. Guaranteed by design, not subject to production testing.

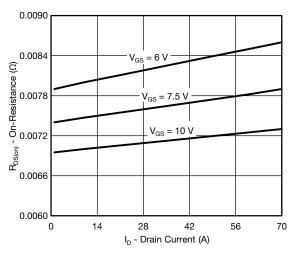
Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.



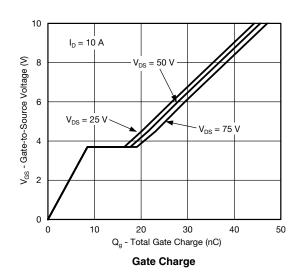
TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

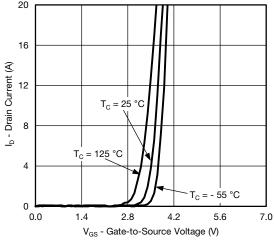


Output Characteristics

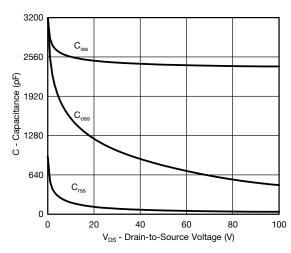


On-Resistance vs. Drain Current

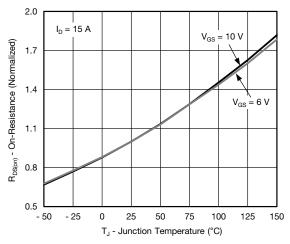




Transfer Characteristics



Capacitance



On-Resistance vs. Junction Temperature



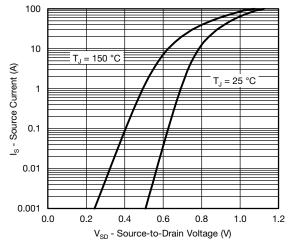
I_D = 15 A

T_J = 125 °C

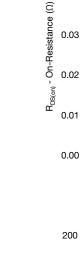
8

10

TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



Source-Drain Diode Forward Voltage



0.05

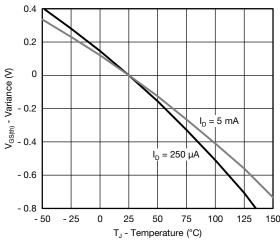
0.04

0

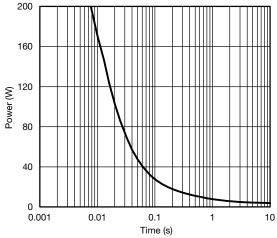
 $\label{eq:VGS} \mbox{V}_{\mbox{GS}} \mbox{ - Gate-to-Source Voltage (V)}$ On-Resistance vs. Gate-to-Source Voltage

T_J = 25 °C

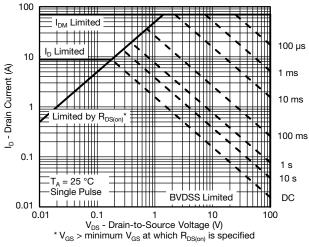
6



Threshold Voltage



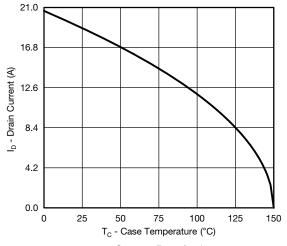
Single Pulse Power, Junction-to-Ambient



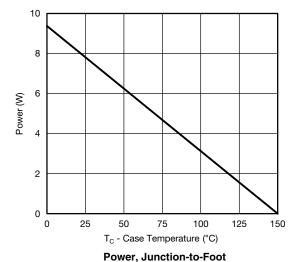
Safe Operating Area, Junction-to-Ambient

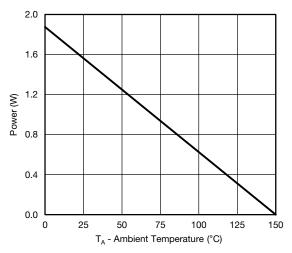


TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



Current Derating*



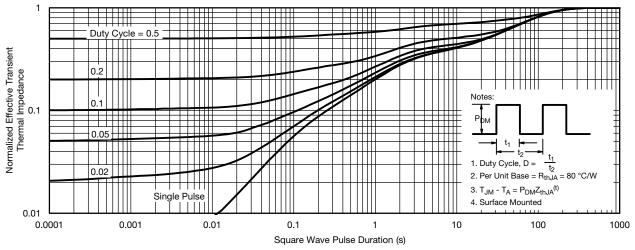


Power, Junction-to-Ambient

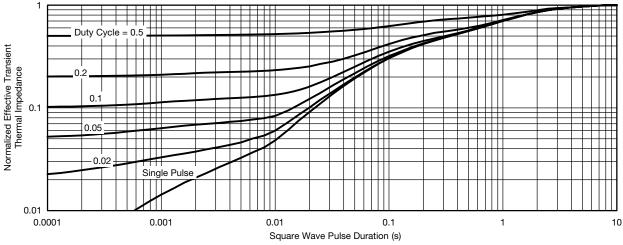
^{*} The power dissipation P_D is based on $T_{J(max)} = 150$ °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.



TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



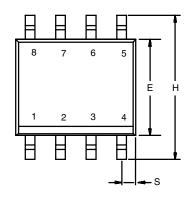
Normalized Thermal Transient Impedance, Junction-to-Ambient

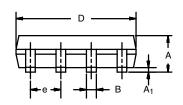


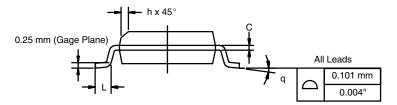
Normalized Thermal Transient Impedance, Junction-to-Foot



SOIC (NARROW): 8-LEAD JEDEC Part Number: MS-012





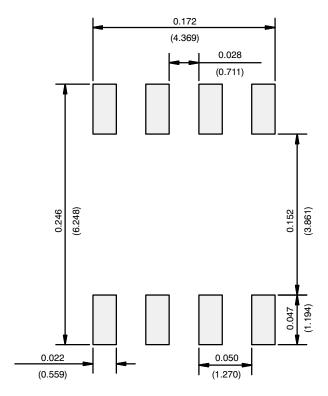


	MILLIM	IETERS	INCHES			
DIM	Min	Max	Min	Max		
Α	1.35	1.75	0.053	0.069		
A ₁	0.10	0.20	0.004	0.008		
В	0.35	0.51	0.014	0.020		
С	0.19	0.25	0.0075	0.010		
D	4.80	5.00	0.189	0.196		
Е	3.80	4.00	0.150	0.157		
е	1.27 BSC		0.050 BSC			
Н	5.80	6.20	0.228	0.244		
h	0.25	0.50	0.010	0.020		
L	0.50	0.93	0.020	0.037		
q	0°	8°	0°	8°		
S	0.44	0.64	0.018	0.026		
ECN: C-06527-Rev. I, 11-Sep-06						

DWG: 5498



RECOMMENDED MINIMUM PADS FOR SO-8



Recommended Minimum Pads Dimensions in Inches/(mm)



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